

Week 13: Drift & Diffusion Announcements

Drift & Diffusion of Carriers

- Last class we talked about qualitatively how drift and diffusion in a pn junction led to a built in voltage across the junction
- This built in voltage is what:
 - Causes a turn on voltage for diodes
 - Results in rectifying IV curve for a diode
 - Allows a solar cell to result in an output of current (rather than the solar generated electrons and holes recombining)

What causes diffusion?

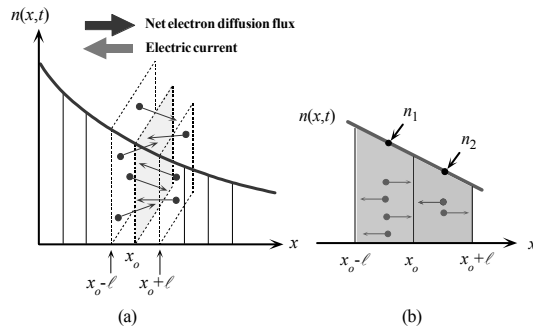


Fig. 5.29: (a) Arbitrary electron concentration $n(x,t)$ profile in a semiconductor. There is a net diffusion (flux) of electrons from higher to lower concentrations. (b) Expanded view of two adjacent sections at x_0 . There are more electrons crossing x_0 coming from left ($x_0 - l$) than coming from right ($x_0 + l$).

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Mathematical Look at Diffusion

$$\Gamma = \frac{\Delta N}{A \Delta t}$$

$$J = Q \Gamma$$

$$\Gamma_e = \frac{\frac{1}{2} n_1 \ell - \frac{1}{2} n_2 \ell}{\tau} = -\frac{\ell}{2\tau} (n_2 - n_1)$$

$$(n_2 - n_1) = \frac{dn}{dx} \Delta x = \frac{dn}{dx} \ell$$

$$\Gamma_e = -\frac{\ell^2}{2\tau} \frac{dn}{dx} = -D \frac{dn}{dx}$$

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D for Electrons & Holes

$Q = -e$ for electrons
 $+e$ for holes

$$\mathbf{J} = Q\Gamma$$

$$\Gamma_e = -D_e \frac{dn}{dx} \longrightarrow$$

$$\Gamma_h = -D_h \frac{dp}{dx}$$

Einstein's Relation

- Einstein's relation relates the diffusion coefficient (D) of electron and holes to the electron and hole mobility

Photoconduction Example

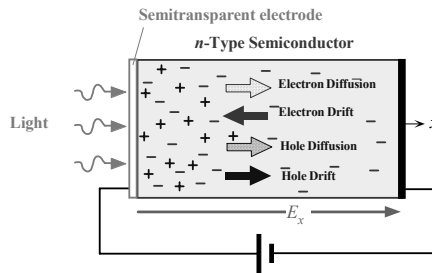


Fig. 5.31: When there is an electric field and also a concentration gradient, charge carriers move both by diffusion and drift. (E_x is the electric field.)

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Drift and Diffusion

- In photoconduction example:

$$J_e = en\mu_e E_x + eD_e \frac{dn}{dx}$$

$$J_h = ep\mu_h E_x - eD_h \frac{dp}{dx}$$

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Resulting Built-in Voltage

- The built-in voltage results from the drift and diffusion terms equilibrating (canceling each other out)

$$J_e = en\mu_e E_x + eD_e \frac{dn}{dx} = -en\mu_e \frac{dV}{dx} + eD_e \frac{dn}{dx} = 0$$

$$e \frac{kT\mu_e}{e} \frac{dn}{dx} = en\mu_e \frac{dV}{dx}$$

$$\int_{V_1}^{V_2} dV = \frac{kT}{e} \int_{n_1}^{n_2} \frac{dn}{n}$$

$$V_2 - V_1 = \frac{kT}{e} \ln\left(\frac{n_2}{n_1}\right)$$

Continuity Equation

- We are also often concerned with a change in the carrier concentration with time
 - This is what results when carriers diffuse or drift away
- The continuity equation quantifies the change in carriers with time as a function of location
- Steady state continuity equation is when the total amount of carriers is conserved (none is being added or subtracted)

Continuity Equation for Holes

$$\frac{\partial p_n}{\partial t} = -\frac{1}{e} \left(\frac{\partial J_h}{\partial x} \right) - \frac{p_n - p_{no}}{\tau_h} + G_{ph}$$

e = electronic charge (1.60218×10^{-19} C), J_h = hole current due to drift and diffusion, x = position, p_n = hole concentration in an n -type semiconductor, p_{no} = equilibrium minority carrier (hole concentration in an n -type semiconductor) concentration, τ_h = hole recombination time (lifetime), G_{ph} = photogeneration rate at x at time t , t = time

Continuity Equation with Uniform Photogeneration

$$\frac{\partial \Delta p_n}{\partial t} = -\frac{\Delta p_n}{\tau_h} + G_{ph}$$

$\Delta p_n = p_n - p_{no}$ is the excess hole concentration, t = time, τ_h = hole recombination time (lifetime), G_{ph} = photogeneration rate at x at time t

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Steady State Decay in Minority Carrier Lifetime

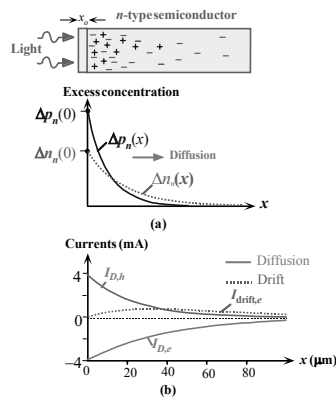


Fig. 5.34: (a) Steady state excess carrier concentration profiles in an n -type semiconductor that is continuously illuminated at one end. (b) Majority and minority carrier current components in open circuit. Total current is zero.

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Steady State Decay in Minority Carrier Lifetime

$$\frac{\partial p_n}{\partial t} = -\frac{1}{e} \left(\frac{\partial J_h}{\partial x} \right) = -\frac{p_n - p_{no}}{\tau_h}$$

$$\Delta p_n(x) = \Delta p_n(x=0) \exp\left(-\frac{x}{L_h}\right)$$

$$L_h = \sqrt{D_h \tau_h}$$